

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10607907	SNADER ET AL.
	Examiner	Art Unit
	Zhen, Li B	2194

SEARCHED

Class	Subclass	Date	Examiner
719	328	7/21/2007	LZ
715	507, 780	7/21/2007	LZ
update	search	12/12/07	LZ
update	search	5/21/2008	LZ
update	search	9/11/2008	LZ
update	search	2/27/2009	LZ
update	search	7/5/2009	LZ
update	search	1/7/2010	LZ
update	search	6/28/2010	LZ

SEARCH NOTES

Search Notes	Date	Examiner
EAST (US-PGPUB;USPAT;USOCR;EPO;DERWENT;IBMTDB) See search history printout	7/21/2007	LZ
EAST (US-PGPUB;USPAT;USOCR;EPO;DERWENT;IBMTDB) See search history printout	12/12/07	LZ
EAST (US-PGPUB;USPAT;USOCR;EPO;DERWENT;IBMTDB) See search history printout	5/21/2008	LZ
EAST (US-PGPUB;USPAT;USOCR;EPO;DERWENT;IBMTDB) See search history printout	9/11/2008	LZ
EAST (US-PGPUB;USPAT;USOCR;EPO;DERWENT;IBMTDB) See search history printout	7/5/2009	LZ
EAST (US-PGPUB;USPAT;USOCR;EPO;DERWENT;IBMTDB) See search history printout	1/7/2010	LZ
EAST (US-PGPUB;USPAT;USOCR;EPO;DERWENT;IBMTDB) See search history printout	6/28/2010	LZ

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner